

Recent developments of resonator measurements for emerging materials and technologies

M. Olszewska-Placha, M. Celuch QWED Sp. z o.o., Poland







What are resonant methods and why we use them

What resonant methods we know

How these resonant methods work

Presentation will be illustrated with full-wave electromagnetic modeling with QuickWave[™] software by



Resonant methods for broadband material characterisation



Resonator methods – motivation and background (1)

Resonance in practice: given fixed strength of Signal(in), at resonance Signal (out) is strongest



Resonator methods – motivation and background (2)

Resonance in theory: non-zero electromagnetic fields exist in isolated structures (no excitation). Field properties are well-defined and linked to material properties. E.g. for cylindrical cavities:



Cylindrical resonator: TE011 mode







Cylindrical resonator: single-mode versus multi-mode operation



Resonators are multimode devices.

Hence formally, material measurement can be performed at many frequencies in the same resonator.

However, some modes provide highest accuracy of material characterization. Some are difficult to excite.

Software provided with the resonator in compatible only with modes pre-selected by the vendor.

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Among the popularly available resonators, BCDR and FPOR work as multi-modal.

Resonator methods – motivation and background (3) **TM010**

TE010



TE modes to measure in-plane component of Dk, Df SCR, SPDR, FPOR



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TM modes to measure out-of-plane component of Dk, Df







some ultralow loss dielectric crystals..", Meas. Sci. Technol. 10 (1999).



Full characterisation of anisotropic materials (like crystals) requires both measurements.

Split Cylinder Resonator (SCR) – basics & operation







TE011 mode



Operation workflow



Discrete
 High measurement precision
 Can be sensitive to many user errors
 points from 10
 Typically interpolated to 5G mmWay

- Typically interpolated to 5G mmWaves
 Typically in-plane component of permittivity
- Typical sample thicknesses around 100 um
- Support temperature sweep measurement
- IPC-TM-650 2.5.5.13
- https://www.keysight.com/us/en/assets/7018-06384/brochures/5992-3438.pdf

Split-Post Dielectric Resonator (SPDR) - basics



- resonant mode with EM fields mostly confined in and between those ceramic posts
 → minimial losses in metal enclosure
- H-field is only vertical at the side wall of the enclosure \rightarrow circumferential currents
- \rightarrow no radiation through slot
- E-field tangential to SUT

 \rightarrow air slots between SUT and posts have negligible effect

• easy SUT insertion through slot, no dismatling





Split-post dielectric	Discrete	High measurement precision
resonator (SPDR)	frequency	Easy to use
	points from 1	 Insensitive to many user errors
	GHz up to 15	 Typically in-plane component of permittivity
	GHz	 Typically extrapolated to 5G mmWaves
		 Typical sample thicknesses less than 1 mm
		 IEC 61189-2-721:2015
		 https://www.gwed.com.pl/resonators_spdr.html
		 https://www.keysight.com/us/en/assets/7018-01416/application
Device Packagin	g 2021	notes/5989-5384.pdf



Split-Post Dielectric Resonator (SPDR) – modelling results









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Split-Post Dielectric Resonator (SPDR) – operation (1)



For many practical materials, measuring only abs (S21) provides appropriate accuracy.

Device Packaging 2021 Keysight Option N1500A uses S21 (amplitude & phase) which helps enhance accuracy (*under study in iNEMI project*).

Balanced-type circular disk resonator (BCDR) – basics & operation















Set shim sheet



Operation workflow

Set center electrode





	No. of Concession, Name	ST	4	
	N		1	
	-	3	Y	



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- High measurement precision
- Requires full 2-port calibration (mechanical to 110 GHz or electrical
- Typically out-of-plane component of permittivity
- Typical sample thicknesses less than 1 mm
- https://www.keysight.com/us/en/assets/7120-1214/flyers/N1501AE11-67-Balanced-Type-Circular-Disk-Resonator-BCDR.pdf NEMI









Clamp and measure

Balanced-type circular disk resonator (BCDR) – modelling



Balanced-type circular disk resonator (BCDR) – modelling



Start at=1(f_exc: 40.4 Plane: XY Ang: 0 Layer=1(0. Name: BCDR1r Start at=95 f_exc: 40.4 Plane: XY Ang: 0 Layer=1(0. Name: BCDR1r



@ 95.06 GHz, air

1 0000000

Start at=6; f exc; 95.(Plane; XY And

@ 55.57 GHz, sample



Fabry-Perot Open Resonator (FPOR)



Millimetre – wave characterisation of dielectric materials



Operational frequency range: Standard: 20 – 50 GHz Advanced: 75 – 110 GHz

- Single device
- Spectrum: 20-110 GHz
- Frequency resolution: ca. 1.5 GHz
- Dk accuracy: $\Delta \varepsilon / \varepsilon < 0.5 \%$
- Df range: $10^{-5} < tan \delta < 10^{-2}$
- Sample diameter: > 3 inches
- Sample thickness: < 2 mm
- Fully automated measurement: (ca. 10 minutes)

Fabry-Perot open resonator (FPOR, also called opencavity) Discrete frequencies between 20 GHz up to 110

GHz

- High measurement precision
- Can be sensitive to many user errors
- Uncertainty increases with increasing frequency
- Typically in-plane component of permittivity
- JIS R1660-2
- https://www.qwed.com.pl/resonators.html#ResonatorFPOR
- <u>https://www.keysight.com/main/editorial.jspx?cc=US&lc=eng&cke</u> y=2276755&nid=null&id=2276755



Fabry-Perot Open Resonator (FPOR) – basics..





Gaussian **TEM00q** modes

Electric field distribution - simulation model in QuickWave software

Bridging the gap between classical resonant methods and free space methods





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Fabry-Perot Open Resonator (FPOR) – basics.. ...and modeling

- the extraction of complex permittivity of a dielectric MUT is made with the aid of electromagnetic model
- □ classical solution is based on a characteristic equation
- novel EM model of the FPOR based on conformal transformation is employed
- □ reducing the FPOR's model to a scalar one-dimensional multilayer problem



better accuracy than alternative solutions







Fabry-Perot Open Resonator (FPOR) – measurement concept



Measurement:

Resonant frequency and Q factor

Electromagnetic model

simulation

Dielectric constant and loss tangent



 $\Phi_{\rm m}$ (mm)

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@ multiple frequencies

Challenges for user

- mode identification
- mode tracking among plenty of other modes occurring in the FPOR

Solution

- Dedicated control software
- Automatic adaptive mode tracking algorithm
- No user intervention needed

Fabry-Perot Open Resonator (FPOR) – operation (1)



1. Connect the FPOR to VNA and PC with control app.

PC app invoked and controlled measurement – fully automatic Total measurement time: 10min

5. Material parameters at consecutive frequencies (modes) are extracted automatically





nd modes of the empty resonator

Operation workflow

Measurement time for standard 20-50GHz band: 10min

Connect to VNA: Connect TEM0015 @ 11.69GHz Connect to motor driver and reset motor position Reset TEM0017 @ 13.19GH; TEM0019 @ 14.69GH; ample thickness [mm]: 0. TEM0021 @ 16.19GH; The number of measurement cycles: TEM0023 @ 17.69GH; TEM0025 @ 19.19GH: The mode number to be tracked at first: TEM0027 @ 20.69GHz FEM0027 @ 20.69GH; Electric thickness of the sample at the first tracked mode is over the half of the wavelength : TEM0029 @ 22.19GH; stimated dielectric constant: 3.1 TEM0031 @ 23.69GH; TEM0033 @ 25.19GH; TEM0035 @ 26.69GH; Results Dielectric constant Loss tangent TEM0037 @ 28.19GH; TEM0039 @ 29.69GH; TEM0041 @ 31.18GH; TEM0043 @ 32.68GH; TEM0045 @ 34.18GH; TEM0047 @ 35.68GHz TEM0049 @ 37.18GHz TEM0051 @ 38.68GHz TEM0053 @ 40.18GHz TEM0055 @ 41.68GHz TEM0057 @ 43.18GHz TEM0059 @ 44.68GHz TEM0061 @ 46.17GHz TEM0063 @ 47.67GHz TEM0065 @ 49.17GHz Check all Uncheck all First mode search: 35 Auto Manual Frequency (GHz) Measure



2. Measure "empty FPOR"

and Q-factor at M..N modes)

(resonant frequency

3. Insert the sample into FPOR 4. Automatic procedure finds M..N modes of sample-loaded FPOR

FPOR & in-house Q-meter

20-40 GHz operation range14 frequency points20s per frequency point



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Fabry-Perot Open Resonator (FPOR) – operation (2)



Q-factor of an empty Fabry-Perot Open Resonator increases with frequency from ca. 1.5×10^5 at 20 GHz up to ca. 2.7×10^5 at 50 GHz.

Estimated thickness limitation



Due to coupling with spurious modes that slightly alter resonant frequencies of the measured modes, the thickness of the sample of known dielectric constant is limited.



Fabry-Perot Open Resonator (FPOR) – results (1)





80

80

100

FPOR with OML frequency extenders operating in 75-110 GHz range.



Fabry-Perot Open Resonator (FPOR) – results (2)





FPOR & in-house Q-meter



Fabry-Perot Open Resonator (FPOR) – in-plane anisotropy

With appropriately designed feeding loops, FPOR is capable of linear E-field polarization and hence detecting in-plane anisotropy:





Resonances detected for **BoPET** sample (t = 0.100 mm), turned in xy plane.

BOPET (biaxially-oriented PET) involves thermal drawing in two in-plane directions with substantially different draw ratios, followed by crystallization. Hence, it is in-plane anisotropic.

For PETG (non-crystalline copolyesters, isotropic), resonant frequency does not depend on angular position of the sample.

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T.Karpisz et al, "Measurement of in-plane anisotropy of dielectric materials with a Fabry-Perot open resonator", Proc. Mi

Fabry-Perot Open Resonator (FPOR) – in-plane anisotropy results





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T.Karpisz et al, "Measurement of in-plane anisotropy of dielectric materials with a Fabry-Perot open resonator", Proc. Mi



2D imaging of material parameters



2D surface map of dielectric constant of quartz



2D surface map of resistivity of semiconductor wafers





*courtesy L-IMP, Poland

2D surface map of measured Q-factor of "QWED" pattern made of organic semiconductor deposited on quartz Measured scan of Q-factor





*courtesy MateriaNova, Belgium







Fully automated *measurement procedure*

Material homogeneity testing

For qualitative and quantitative material testing

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Concluding remarks



- Growing interest and need for broadband material characterisation (e.g. due to advances in telecommunication systems)
- Frequency spectrum covered by several different methods & full spectrum methods
- □ Each method has specific features, which can make it preferable for a particular application (e.g., different sample Dk / Df, thickness, expected anisotropy; frequency & temperature range of use)
- iNEMI project benchmarks resonant methods for material characterisation (popular and recent developments)
- iNEMI initiative will bring practical guidelines for the industry



Acknowledgement



The work of QWED presented has received funding from the

European Union's Horizon 2020

research and innovation programme



under grant agreement

NanoBat No 861962.

(website: www.nanobat.eu)





Thank you for your attention!!!